

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY DOCKET NO. 249475US0		SERIAL NO. 10/802,887 New Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Chiaki TANAKA, et al.			
				FILING DATE 3-18-04 Herewith		GROUP 1756	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
MC	AA	2,297,691	04/04/03	CARLSON <i>10/1942</i>			
	AB	2,931,699	04/05/60	PETERSON			
	AC	6,620,443	12/08/03	SUGIYAMA ET AL			
	AD	6,323,449	07/22/03	SHIMADA ET AL			
	AE	6,492,079	12/10/02	SHIMADA ET AL			
	AF	6,548,216	04/15/03	KAWAMURA ET AL			
	AG	6,544,701	04/08/03	TADOKORO ET AL			
	AH	6,485,648	10/15/02	TADOKORO ET AL			
	AI	6,524,761	02/25/03	SHIMADA ET AL			
	AJ	6,687,141	12/23/03	IWAMOTO ET AL			
	AK	6,313,288	11/08/01	SHIMADA ET AL			
	AL	6,303,736	10/16/01	KAWAMURA ET AL			
	AM	6,187,494	02/13/01	KAWAMURA ET AL			
MC	AN	6,172,176	01/09/01	TANAKA ET AL			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	YES	NO
MC	AO	43-24748	10/25/43	Japan			III
	AP	60-020344	09/21/89	Japan (English Abstract only)			
	AQ	64-015753	01/18/89	Japan (English Abstract only)			
	AR	02-082267	03/22/80	Japan (English Abstract only)			
	AS	03-229264	10/11/91	Japan (English Abstract only)			
	AT	03-041470	02/21/91	Japan (English Abstract only)			
	AU	11-305488	11/05/89	Japan (English Abstract only)			
MC	AV	62-063840	03/20/87	Japan (English Abstract only)			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Mark Chapman/					Date Considered 04/26/2006		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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1-31-01

Form PTO 1640 (Rev. 1-20-01)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 249475US0	SERIAL NO. 10/802,887 New Application	
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
HC	AA 5,842,353	08/24/99	TANAKA ET AL			
	AB 5,723,243	03/03/98	SASAKI ET AL			
	AC 6,018,014	01/25/00	NAGAI ET AL			
	AD 5,840,454	11/24/98	NAGAI ET AL			
	AE 6,056,757	05/23/00	TANAKA ET AL			
	AF 5,841,588	08/24/97	TANAKA ET AL			
	AG 6,271,356	08/07/01	SHIMADA ET AL			
	AH 6,184,362	08/07/01	SHIMADA ET AL			
	AI 6,103,435	08/15/00	SHIMADA ET AL			
	AJ 5,881,124	11/02/99	SHIMADA ET AL			
	AK 5,808,155	08/15/98	SHIMADA ET AL			
	AL 5,663,407	09/02/97	SHIMADA ET AL			
	AM 5,547,782	08/20/96	SHIMADA ET AL			
HC	AN 5,434,028	07/18/95	SHIMADA ET AL			
FOREIGN PATENT DOCUMENTS						
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AO						
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AQ						
AR						
AS						
AT						
AU						
AV						
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